



RADIO TEST REPORT

Test Report No. : 31DE0278-HO-01-A

Applicant : Roland Corporation
Type of Equipment : Amplifier
Model No. : BA-55
FCC ID : SOP410511F
Test regulation : FCC Part 15 Subpart C: 2010
Test Result : Complied

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2. The results in this report apply only to the sample tested.
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Date of test: March 22 to April 21, 2011

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SECTION 1: Customer information

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SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Amplifier
Model No. : BA-55
Serial No. : Refer to Section 4, Clause 4.2
Rating : AC 120V/60Hz
Receipt Date of Sample : March 22, 2011
Country of Mass-production : China
Condition of EUT : Production prototype
(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT : No Modification by the test lab

2.2 Product Description

General Specification

Clock frequency(ies) in the system : CPU: 16MHz

Radio Specification

Radio Type : Transceiver
Frequency of Operation : 2404-2476MHz
Modulation : GFSK
Power Supply (radio part input) : DC 3.3V
Antenna type : PCB antenna
Antenna Connector type : UFL
Antenna Gain : 5.5dBi (max)

Channel Table	T1-1 2404MHz T1-2 2420MHz T1-3 2436MHz T1-4 2452MHz T1-5 2468MHz
	T2-1 2413MHz T2-2 2429MHz T2-3 2445MHz T2-4 2461MHz T2-5 2476MHz

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C: 2010, final revised on December 6, 2010 and effective January 5, 2011

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.207 Conducted limits
Section 15.247 Operation within the bands 902-928MHz,
2400-2483.5MHz, and 5725-5850MHz

3.2 Procedures and results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted Emission	FCC: ANSI C63.4:2003 7. AC powerline Conducted Emission measurements IC: RSS-Gen 7.2.4	FCC: Section 15.207 IC: RSS-Gen 7.2.4	QP 12.9dB, 0.42983MHz, N AV 12.7dB, 0.42841MHz, L	Complied	-
6dB Bandwidth	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" IC: RSS-Gen 4.6.2	FCC: Section 15.247(a)(2) IC: RSS-210 A8.2(a)	See data.	Complied	Conducted
Maximum Peak Output Power	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" IC: RSS-Gen 4.8	FCC: Section 15.247(b)(3) IC: RSS-210 A8.4(4)		Complied	Conducted
Power Density	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" IC: -	FCC: Section 15.247 (e) IC: RSS-210 A8.2(b)		Complied	Conducted
Spurious Emission Restricted Band Edges	FCC: "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247" IC: RSS-Gen 4.9	FCC: Section15.247(d) IC: RSS-210 A8.5 RSS-Gen 7.2.3	6.5dB 4808.000MHz, AV, Vert.	Complied	Conducted/ Radiated

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

* In case any questions arise about test procedure, ANSI C63.4: 2003 is also referred.

FCC 15.31 (e)

This EUT provides stable voltage (DC3.3V) constantly to RF Part regardless of input voltage. Therefore, this EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99% Occupied Bandwidth	IC: RSS-Gen 4.6.1	IC: RSS-Gen 4.6.1	N/A	-	Conducted

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

EMI

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Test room (semi-anechoic chamber)	Conducted emission (+dB)
	150kHz-30MHz
No.1	3.1dB
No.2	3.3dB
No.3	3.7dB
No.4	3.2dB

Test room (semi-anechoic chamber)	Radiated emission						
	(3m*)(+dB)				(1m*)(+dB)		(0.5m*)(+dB)
	9kHz -30MHz	30MHz -300MHz	300MHz -1GHz	1GHz -10GHz	10GHz -18GHz	18GHz -26.5GHz	26.5GHz -40GHz
No.1	3.5dB	5.1dB	5.2dB	4.8dB	5.1dB	4.4dB	4.3dB
No.2	4.0dB	5.1dB	5.2dB	4.8dB	5.0dB	4.3dB	4.2dB
No.3	4.2dB	4.7dB	5.2dB	4.8dB	5.0dB	4.5dB	4.2dB
No.4	4.0dB	5.0dB	5.1dB	4.8dB	5.0dB	5.1dB	4.2dB

*3m/1m/0.5m = Measurement distance

Power meter (+dB)	
Below 1GHz	Above 1GHz
1.0dB	1.0dB

Antenna terminal conducted emission and Power density (+dB)			Antenna terminal conducted emission (+dB)		Channel power (+dB)
Below 1GHz	1GHz-3GHz	3GHz-18GHz	18GHz-26.5GHz	26.5GHz-40GHz	
1.0dB	1.1dB	2.7dB	3.2dB	3.3dB	1.5dB

Conducted Emission test

The data listed in this test report has enough margin, more than the site margin.

Radiated emission test(3m)

The data listed in this test report has enough margin, more than the site margin.

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3.5 Test Location

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	FCC Registration Number	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	313583	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	655103	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	148738	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	134570	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	-	4.0 x 4.5 x 2.7m	4.75 x 5.4 m	-
No.6 measurement room	-	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	-	8.0 x 4.5 x 2.8m	2.0 x 2.0m	-
No.10 measurement room	-	-	2.6 x 2.8 x 2.5m	2.4 x 2.4m	-
No.11 measurement room	-	-	3.1 x 3.4 x 3.0m	2.4 x 3.4m	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test set up, Data of EMI, and Test instruments

Refer to APPENDIX.

SECTION 4: Operation of E.U.T. during testing

4.1 Operating Mode(s)

Test Item	Operating Mode	Tested Antenna	Tested frequency
Conducted Emission, Spurious Emission (Radiated / Conducted), 6dB Bandwidth, Power Density, 99% Occupied Bandwidth	Transmitting (Tx) *1)	2 *2)	2404MHz 2440MHz *3) 2476MHz
Maximum Peak Output Power	Transmitting (Tx) *1)	1, 2	2404MHz 2440MHz *3) 2476MHz
Band Edge Compliance (Radiated / Conducted)	Transmitting (Tx) *1)	2 *2)	2404MHz 2476MHz
<p>*Transmitting duty was 100% on all tests. *Power of the EUT was set by the software as follows; Power settings: -12dBm Software: V1.0 *This setting of software is the worst case. Any conditions under the normal use do not exceed the condition of setting. In addition, end users cannot change the settings of the output power of the product.</p> <p>*1) The EUT transmits with GFSK modulated. *2) The test was performed with the worst antenna: Antenna 2 as a representative after compared with Antenna 1 and Antenna 2. Antenna 1 and Antenna 2 have completely identical EMC characteristics. *3) Used frequencies of the EUT are 2404/2420/2436/2452/2468/2413/2429/2445/2461/2476MHz (total: 10 channel), but as the EUT can transmit at 2440MHz technically, the test was performed at 2440MHz as a Mid channel. In addition, there was no difference in power level among 2440MHz, 2436MHz and 2445MHz.</p>			

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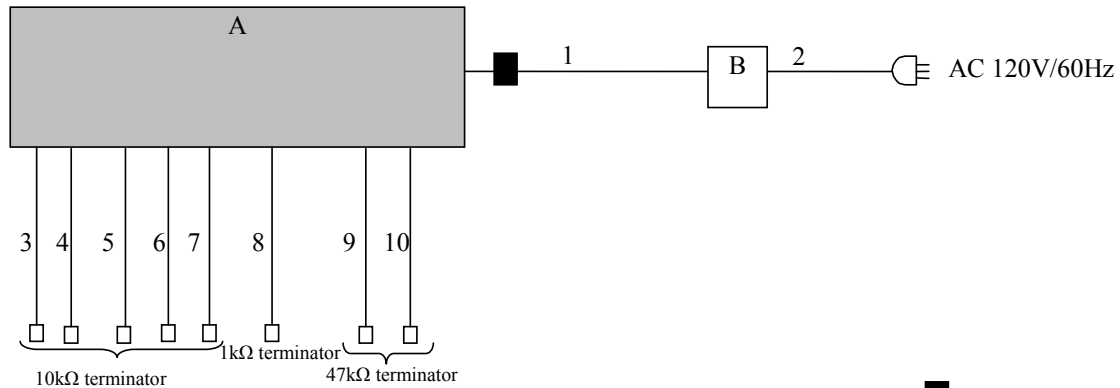
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4.2 Configuration and peripherals



■ : Standard Ferrite Core

* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

Description of EUT

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Amplifier	BA-55	101063 *1) 101060 *2)	Roland Corporation	EUT
B	AC Adaptor	PSB-12U	1039R	Roland Corporation	-

*1) Used for Antenna Terminal conducted test

*2) Used for Conducted Emission test and Radiated Emission test

List of cables used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	DC Cable	1.7	Unshielded	Unshielded	-
2	AC Cable	1.0	Unshielded	Unshielded	-
3	LINE Cable	3.0	Shielded	Shielded	RCA in Lch
4	LINE Cable	3.0	Shielded	Shielded	RCA in Rch
5	INST Cable	3.0	Shielded	Shielded	Lch
6	INST Cable	3.0	Shielded	Shielded	Rch
7	LINE Cable	3.0	Shielded	Shielded	Stereo in
8	MIC Cable	3.0	Shielded	Shielded	-
9	LINE Cable	3.0	Shielded	Shielded	RCA out Lch
10	LINE Cable	3.0	Shielded	Shielded	RCA in Rch

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SECTION 5: Conducted Emission

Test Procedure and conditions

EUT was placed on a urethane platform of nominal size, 1.0m by 1.5m, raised 0.8m above the conducting ground plane.

The rear of tabletop was located 40cm to the vertical conducting plane. The rear of EUT, including peripherals aligned and flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80cm from a Line Impedance Stabilization Network (LISN)/ Artificial mains Network (AMN) and excess AC cable was bundled in center.

For the tests on EUT with other peripherals (as a whole system)

I/O cables that were connected to the peripherals were bundled in center. They were folded back and forth forming a bundle 30cm to 40cm long and were hanged at a 40cm height to the ground plane. All unused 50ohm connectors of the LISN(AMN) were resistivity terminated in 50ohm when not connected to the measuring equipment.

The AC Mains Terminal Continuous disturbance Voltage has been measured with the EUT in a Semi Anechoic Chamber.

The EUT was connected to a LISN (AMN).

An overview sweep with peak detection has been performed.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Detector	: QP and AV
Measurement range	: 0.15-30MHz
Test data	: APPENDIX
Test result	: Pass

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SECTION 6: Radiated Spurious Emission

Test Procedure

It was measured based on "2. Radiated emission test" of "Guidance on Measurement of Digital Transmission Systems Operating under Section 15.247".

EUT was placed on a urethane platform of nominal size, 0.5m by 1.0m, raised 0.8m above the conducting ground plane.

The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

The height of the measuring antenna varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization with the Test Receiver, or the Spectrum Analyzer.

The measurements were made with the following detector function of the test receiver and the Spectrum analyzer (in linear mode).

The test was made with the detector (RBW/VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

Test Antennas are used as below;

Frequency	Below 30MHz	30MHz to 300MHz	300MHz to 1GHz	Above 1GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

Frequency	Below 1GHz	Above 1GHz	
Instrument used	Test Receiver	Spectrum Analyzer	
Detector	QP	PK	AV
IF Bandwidth	BW 120kHz(T/R)	RBW: 1MHz VBW: 3MHz	RBW: 1MHz VBW: 10Hz *1)
Test Distance	3m	3m (below 10GHz), 1m*2) (above 10GHz)	

*1) Frequency shift width is much lower than 1MHz. Therefore, the measurement was performed with duty 100%.

*2) Distance Factor: $20 \times \log(3.0\text{m}/1.0\text{m}) = 9.5\text{dB}$

- The carrier level and noise levels were confirmed at each position of X and Y axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

Measurement range : 30M-25GHz
Test data : APPENDIX
Test result : Pass

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SECTION 7: Antenna Terminal Conducted Tests

Test Procedure

The tests were made with below setting connected to the antenna port.

Test	Span	RBW	VBW	Sweep time	Detector	Trace	Instrument used
6dB Bandwidth	10MHz	100kHz	300kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99% Occupied Bandwidth	Enough width to display 20dB Bandwidth	1 to 3% of Span	Three times of RBW	Auto	Peak	Max Hold	Spectrum Analyzer
Maximum Peak Output Power	-	-	-	Auto	Peak	-	Power Meter (Sensor: 50MHz BW)
Power Density	1.5MHz	3kHz	100kHz	500sec	Peak	Max Hold	Spectrum Analyzer *1)
Conducted Spurious Emission *2)	9kHz to 150kHz	200Hz	620Hz	Auto	Peak	Max Hold	Spectrum Analyzer
	150kHz to 30MHz	10kHz	30kHz				
	30MHz to 25GHz (Less or equal to 5GHz)	100kHz	300kHz				
*1) PSD Option 1 of "Guidance on Measurement of Digital Transmission Systems Operating under Section15.247 ". *2) In the frequency range below 30MHz, RBW was narrowed to separate the noise contents. Then, wide-band noise near the limit was checked separately, however the noise was low enough for the limit. (9kHz-150kHz:RBW=200Hz, 150kHz-30MHz:RBW=10kHz)							

The test results and limit are rounded off to two decimals place, so some differences might be observed.

Test data : APPENDIX
Test result : Pass